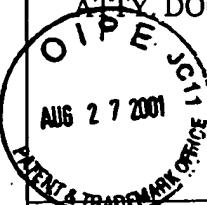


<p>Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement (Use several sheets if necessary)</p>			ATTY. DOCKET NO: 5150-55200 		SERIAL NO: 09/832,505		
<p>APPLICANT: Qian et al.</p>							
FILING DATE: April 10, 2001					GROUP: 2858		
U.S. PATENT DOCUMENTS							
EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>TN</i>	A1	5,751,149	05/12/1998	Oberg et al.			
FOREIGN PATENT DOCUMENTS							
EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION. YES/NO
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
<i>TN</i>	A2	Agilent Technologies application Note 1304-2: Time domain Reflectometry Theory, dated 11/2000, 17 pages.					
<i>TN</i>	A3	Shie Qian and Dapang Chen, Joint Time-Frequency Analysis Methods and Applications, Chapter 8, 1996, pp. 181-198.					
EXAMINER: <i>TN</i>				DATE CONSIDERED: 4/28/04			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the patent owner.							